

# Si9410DY\*

## Single N-Channel Enhancement Mode MOSFET

### General Description

This N-Channel Enhancement Mode MOSFET is produced using Fairchild Semiconductor's advance process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

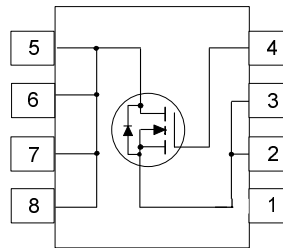
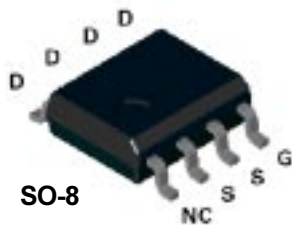
This device is well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

### Features

- 7.0 A, 30 V.  $R_{DS(ON)} = 0.030 \Omega @ V_{GS} = 10 V$   
 $R_{DS(ON)} = 0.050 \Omega @ V_{GS} = 4.5 V$
- Low gate charge.
- Fast switching speed.
- High power and current handling capability.

### Applications

- Battery switch
- Load switch
- Motor controls



### Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage	30	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub>	Drain Current - Continuous (Note 1a)	7.0	A
		30	
P <sub>D</sub>	Power Dissipation for Single Operation (Note 1a)	2.5	W
		1.2	
		1	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

### Thermal Characteristics

R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient (Note 1a)	50	°C/W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case (Note 1)	25	°C/W

### Package Outlines and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
9410	SI9410DY	13"	12mm	2500 units

\* Die and manufacturing source subject to change without prior notification.

## Electrical Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		31		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$ $V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}, T_J = 55^\circ\text{C}$			2 25	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	nA
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-100	nA

### On Characteristics (Note 2)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	1			V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		-4.4		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 7\text{ A}$ $V_{GS} = 5\text{ V}, I_D = 4\text{ A}$ $V_{GS} = 4.5\text{ V}, I_D = 3.5\text{ A}$		0.024 0.034 0.037	0.030 0.040 0.050	$\Omega$
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10\text{ V}, V_{DS} = 5\text{ V}$	30			A
$g_{FS}$	Forward Transconductance	$V_{DS} = 15\text{ V}, I_D = 7\text{ A}$		18		S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$		650		pF
$C_{oss}$	Output Capacitance			345		pF
$C_{rss}$	Reverse Transfer Capacitance			95		pF

### Switching Characteristics (Note 2)

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 25\text{ V}, I_D = 1\text{ A}, R_L = 25\ \Omega$ $V_{GS} = 10\text{ V}, R_{GEN} = 6\ \Omega$		8	30	ns
$t_r$	Turn-On Rise Time			14	60	ns
$t_{d(off)}$	Turn-Off Delay Time			23	150	ns
$t_f$	Turn-Off Fall Time			9	140	ns
$t_{rr}$	Drain-Source Reverse Recovery Time	$I_F = 2\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$		60		nS
$Q_g$	Total Gate Charge	$V_{DS} = 15\text{ V}, I_D = 2\text{ A},$ $V_{GS} = 10\text{ V}$		19	50	nC
$Q_{gs}$	Gate-Source Charge			3.2		nC
$Q_{gd}$	Gate-Drain Charge			4.3		nC

### Drain-Source Diode Characteristics and Maximum Ratings

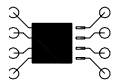
$I_S$	Maximum Continuous Drain-Source Diode Forward Current			2.0		A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 2\text{ A}$ (Note 2)		0.7	1.1	V

#### Notes:

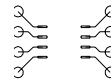
- 1:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a)  $50^\circ\text{ C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz. copper.



b)  $105^\circ\text{ C/W}$  when mounted on a  $0.04\text{ in}^2$  pad of 2 oz. copper.



c)  $125^\circ\text{ C/W}$  on a minimum mounting pad.

Scale 1 : 1 on letter size paper

- 2: Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 2.0\%$

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